TPS7A80低ノイズ、広帯域幅、高PSRR、低ドロップアウト1Aリニア・レギュレータ

1 特長

- イネーブル付きの低ドロップアウト1Aレギュレータ
- 可変出力電圧: 0.8V～6V
- 固定出力電圧: 0.8V～6V
- 広帯域幅で高PSRR:
  - 1kHz時に63dB
  - 100kHz時に57dB
  - 1MHz時に38dB
- 低ノイズ: (14×V_{OUT})μV_{RMS} (標準値) (100Hz～100kHz)
- 4.7μFのセラミック・コンデンサで安定動作
- 非常に優れた負荷/ライン過渡応答
- 総合精度: 3%（負荷/ライン/温度範囲全体）
- 過電流保護および過熱保護
- 超低ドロップアウト: 1A時に170mV (標準値)
- 3mm×3mmのVSON-8 DRBパッケージ

2 アプリケーション

- 通信インフラ
- オーディオ
- 高速I/F (PLL/VCO)

3 概要

TPS7A80低ドロップアウト・リニア・レギュレータ(LDO)ファミリは、出力での電源リップル除去比(PSRR)が極めて高い製品です。このLDOファミリは、高度なBiCMOSプロセスの採用に加え、PMOSFETパス素子の搭載により、非常に低いノイズ、優れた過渡応答、および優れたPSRR性能を実現しています。

TPS7A80ファミリは、4.7μFのセラミック出力コンデンサで安定して動作し、高精度の基準電圧および帰還ループの採用により、すべての負荷、ライン、プロセス、および温度の変動に対してワーストケースでも3%の精度を達成します。

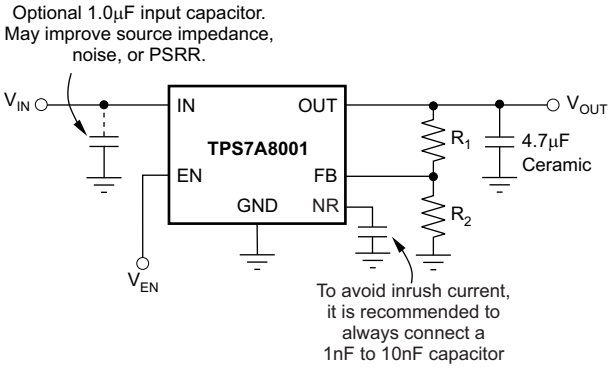
TPS7A80ファミリは、T_J＝－40℃～＋125℃の温度範囲全体で仕様が規定されており、サーマル・パッドを備えた3mm×3mmのVSON-8パッケージで供給されます。

製品情報(1)

型番	パッケージ	本体サイズ(公称)
TPS7A80	VSON (8)	3.00mm×3.00mm

(1) 利用可能なすべてのパッケージについては、このデータシートの末尾にあるパッケージ・オプションについての付録を参照してください。

標準アプリケーション回路



英語版のTI製品についての情報を翻訳したこの資料は、製品の概要を確認する目的で便宜的に提供しているものです。該当する正式な英語版の最新情報は、www.ti.comで閲覧でき、その内容が常に優先されます。TIでは翻訳の正確性および妥当性につきましては一切保証いたしません。実際の設計などの前には、必ず最新版の英語版をご参照くださいますようお願いいたします。

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4 改訂履歴

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Revision I (August 2015) から Revision J に変更 **Page**

- 新しい固定電圧デバイスと関連コンテンツをデータシートに 追加 ... 1
- 新しい固定電圧デバイス・オプションを示すために製品名を汎用品番に 変更 ... 1
- Added SNS pin and description to *Pin Functions* table ... 4
- Changed T_A to T_J in *Recommended Operating Conditions* table ... 5
- Added fixed-voltage-version values to *Electrical Characteristics* table ... 6
- Added test conditions to V_{NR} parameter in *Electrical Characteristics* table ... 6
- Added new note (3) to output accuracy parameter in *Electrical Characteristics* table ... 6
- Deleted typical value for I_{SHDN} in *Electrical Characteristics* table ... 6

Revision H (January 2013) から Revision I に変更 **Page**

- 「*ESD定格*」の表、「*機能説明*」セクション、「*デバイスの機能モード*」、「*アプリケーションと実装*」セクション、「*電源に関する推奨事項*」セクション、「*レイアウト*」セクション、「*デバイスおよびドキュメントのサポート*」セクション、「*メカニカル、パッケージ、および注文情報*」セクション 追加 ... 1
- 「革新的な工場出荷時EEPROMプログラミングを採用した固定出力電圧: 0.8V～5V」の項目を「*特長*」から 削除 ... 1
- 「低ノイズ」の項目で「12.6」を「14」に 変更 ... 1
- Deleted SNS row from *Pin Functions* table ... 4
- Deleted fixed version from V_{OUT} row in *Electrical Characteristics* ... 6
- Deleted ISNS row from *Electrical Characteristics* ... 6

Revision G (April 2012) から Revision H に変更 **Page**

- Updated Figure 8 ... 7

Revision F (March 2012) から Revision G に変更 **Page**

- Changed Thermal Information table values, added new footnote 2, changed footnote 3 ... 5

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Revision E (February 2012) から Revision F に変更 **Page**

- *低ノイズの「特長」項目 変更* 1
- Updated Equation 3 17

Revision D (December 2010) から Revision E に変更 **Page**

- *低ノイズの「特長」項目 変更* 1
- 表紙のアプリケーション回路のキャプション 変更 1
- Updated Figure 12 7
- Updated Figure 26 10
- Added Equation 1 note in *Start-up* section 14
- Updated Equation 3 17

Revision C (September, 2010) から Revision D に変更 **Page**

- 表紙の図を新しい特性グラフに 1
- Revised Figure 17 8
- Changed Figure 18 8

Revision B (August, 2010) から Revision C に変更 **Page**

- データシート・タイトル 変更 1
- 「*特長*」のリストで「*超高PSRR*」を「*広帯域幅で高PSRR*」に 変更 1
- Corrected typos in Figure 21 through Figure 23 9
- Revised first paragraph of *Application Information* to remove phrase *ultra-wide bandwidth* 15

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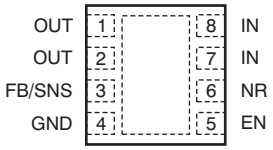
5 Pin Configuration and Functions

DRB Package
8-Pin VSON
Top View



Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
EN	5	I	Driving the enable pin (EN) high turns on the regulator. Driving this pin low puts the regulator into shutdown mode. Refer to *Shutdown* in the *Application and Implementation* section for more details. EN must not be left floating and can be connected to IN if not used.
FB/SNS	3	I	FB (adjustable version only): This pin is the input to the control loop error amplifier and is used to set the output voltage of the device. SNS (fixed versions only): Output voltage sense pin.(1)
GND	4, pad	—	Ground.
IN	7, 8	I	Unregulated input supply.
OUT	1, 2	O	Regulator output. A 4.7-μF or larger capacitor of any type is required for stability.
NR	6	—	Connect an external capacitor between this pin and ground to reduce output noise to very low levels. Also, the capacitor slows down the V_{OUT} ramp (RC softstart).

(1) In order to minimize the trace resistive drop, connect the SNS pin close to the load, and make sure that the trace inductance to the load is also minimized.

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
Voltage	IN	–0.3	7	V
	FB, NR	–0.3	3.6	
	EN	–0.3	V_{IN} + 0.3(2)	
	OUT	–0.3	7	
Current	OUT	Internally Limited		A
Temperature	Operating virtual junction, T_J	–55	150	°C
	Operating free air temperature, T_A	–40	125	
	Storage, T_{stg}	–55	150	

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) V_{EN} absolute maximum rating is V_{IN} + 0.3 V or 7 V, whichever is smaller.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins(1)	±2000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins(2)	±500	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
V_{IN}	Input voltage(1)	2.2	6.5	V
I_{OUT}	Output current	0	1	A
T_J	Operating junction temperature	–40	125	°C
T_A	Operating free air temperature	–40	125	°C

(1) Minimum $V_{IN} = V_{OUT} + V_{DO}$ or 2.2 V, whichever is greater.

6.4 Thermal Information

THERMAL METRIC(1)(2)		TPS7A80 DRB (VSON)(3) 8 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	47.8	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	53.9	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	23.4	°C/W
ψ_{JT}	Junction-to-top characterization parameter	1	°C/W
ψ_{JB}	Junction-to-board characterization parameter	23.5	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	7.4	°C/W

(1) For information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.
(2) For thermal estimates of this device based on PCB copper area, see the TI PCB Thermal Calculator.
(3) Thermal data for the DRB package are derived by thermal simulations based on JEDEC-standard methodology as specified in the JESD51 series. The following assumptions are used in the simulations:
(a) The exposed pad is connected to the PCB ground layer through a 2 × 2 thermal via array.
(b) The top and bottom copper layers are assumed to have a 5% thermal conductivity of copper representing a 20% copper coverage.
(c) This data were generated with only a single device at the center of a JEDEC high-K (2s2p) board with 3 inches × 3 inches copper area. To understand the effects of the copper area on thermal performance, refer to the *Power Dissipation* and *Estimating Junction Temperature* sections.

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6.5 Electrical Characteristics

At T_J = –40°C to +125°C, V_{IN} = $V_{OUT(TYP)}$ + 0.5 V or 2.2 V (whichever is greater), I_{OUT} = 1 mA, V_{EN} = 2.2 V, C_{OUT} = 4.7 µF, and C_{NR} = 0.01 µF (unless otherwise noted). TPS7A8001 tested at V_{OUT} = 0.8 V and V_{OUT} = 6 V. Typical values are at T_J = 25°C.

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
V_{NR}	Internal reference	Adjustable and Fixed V_{OUT} = 1.2 V		0.79	0.8	0.81	V
		Fixed V_{OUT} ≥ 1.8 V		1.23	1.243	1.26	V
V_{OUT}	Output voltage	Adjustable version only (TPS7A8001)		0.8		6	V
		Fixed versions only		1.2		5	V
	Output accuracy(1)(2)	V_{OUT} + 0.5 V ≤ V_{IN} ≤ 6 V, V_{IN} ≥ 2.5 V, 100 mA ≤ I_{OUT} ≤ 500 mA, 0°C ≤ T_J ≤ 85°C		–2%		2%	
		V_{OUT} + 0.5 V ≤ V_{IN} ≤ 6.5 V, V_{IN} ≥ 2.2 V, 100 mA ≤ I_{OUT} ≤ 1 A		–3%	±0.3%	3%	
$\Delta V_{OUT}/\Delta V_{IN}$	Line regulation	$V_{OUT(NOM)}$ + 0.5 V ≤ V_{IN} ≤ 6.5 V, V_{IN} ≥ 2.2 V, I_{OUT} = 100 mA			150		µV/V
$\Delta V_{OUT}/\Delta I_{OUT}$	Load regulation	100 mA ≤ I_{OUT} ≤ 1 A			2		µV/mA
V_{DO}	Dropout voltage(3)	V_{OUT} + 0.5 V ≤ V_{IN} ≤ 6.5 V, V_{IN} ≥ 2.2 V, I_{OUT} = 500 mA, V_{FB} = GND or V_{SNS} = GND				250	mV
		V_{OUT} + 0.5 V ≤ V_{IN} ≤ 6.5 V, V_{IN} ≥ 2.5 V, I_{OUT} = 750 mA, V_{FB} = GND or V_{SNS} = GND				350	mV
		V_{OUT} + 0.5 V ≤ V_{IN} ≤ 6.5 V, V_{IN} ≥ 2.5 V, I_{OUT} = 1 A, V_{FB} = GND or V_{SNS} = GND				500	mV
I_{CL}	Output current limit	V_{OUT} = 0.85 × $V_{OUT(NOM)}$, V_{IN} ≥ 3.3 V	Adjustable	1100	1400	2000	mA
			Fixed	1100		2000	
I_{GND}	Ground pin current	I_{OUT} = 1 mA, adjustable version only			60	100	µA
		I_{OUT} = 1 mA, fixed versions only				120	µA
		I_{OUT} = 1 A				350	µA
I_{SHDN}	Shutdown current (I_{GND})	V_{EN} ≤ 0.4 V, V_{IN} ≥ 2.2 V, R_L = 1 kΩ, 0°C ≤ T_J ≤ 85°C				2	µA
I_{FB}	Feedback pin current (TPS7A8001)	V_{IN} = 6.5 V, V_{FB} = 0.8 V			0.02	1	µA
PSRR	Power-supply rejection ratio	V_{IN} = 4.3 V, V_{OUT} = 3.3 V, I_{OUT} = 750 mA	f = 100 Hz		48		dB
			f = 1 kHz		63		dB
			f = 10 kHz		63		dB
			f = 100 kHz		57		dB
			f = 1 MHz		38		dB
V_N	Output noise voltage	BW = 100 Hz to 100 kHz, V_{IN} = 4.3 V, V_{OUT} = 3.3 V, I_{OUT} = 100 mA	C_{NR} = 0.001 µF		14.6 × V_{OUT}		μV_{RMS}
			C_{NR} = 0.01 µF		14.3 × V_{OUT}		μV_{RMS}
			C_{NR} = 0.1µF		13.9 × V_{OUT}		μV_{RMS}
$V_{EN(HI)}$	Enable high (enabled)	2.2 V ≤ V_{IN} ≤ 3.6 V, R_L = 1 kΩ		1.2			V
		3.6 V < V_{IN} ≤ 6.5 V, R_L = 1 kΩ		1.35			V
$V_{EN(LO)}$	Enable low (shutdown)	R_L = 1 kΩ		0		0.4	V
$I_{EN(HI)}$	Enable pin current, enabled	V_{IN} = V_{EN} = 6.5 V			0.02	1	µA
t_{STR}	Start-up time	$V_{OUT(NOM)}$ = 3.3 V, V_{OUT} = 0%–90% $V_{OUT(NOM)}$, R_L = 3.3 kΩ, C_{OUT} = 4.7 µF	C_{NR} = 1 nF		0.1		ms
			C_{NR} = 10 nF		1.6		ms
UVLO	Undervoltage lockout	V_{IN} rising, R_L = 1 kΩ		1.86	2	2.10	V
	UVLO hysteresis	V_{IN} falling, R_L = 1 kΩ			75		mV
T_{SD}	Thermal shutdown temperature	Shutdown, temperature increasing			160		°C
		Reset, temperature decreasing			140		°C

(1) The TPS7A8001 (adjustable) does not include external resistor tolerances and is not tested at these conditions: V_{OUT} = 0.8 V, 4.5 V ≤ V_{IN} ≤ 6.5 V, and 750 mA ≤ I_{OUT} ≤ 1 A because power dissipation is higher than maximum rating of the package.
(2) The TPS7A8012, TPS7A8018, and TPS7A8033 are not tested at these conditions: 4.5 V ≤ V_{IN} ≤ 6.5 V, and 750 mA ≤ I_{OUT} ≤ 1 A because power dissipation is higher than maximum rating of the package.
(3) V_{DO} is not measured for fixed output voltage devices with VOUT < 1.7 V because minimum V_{IN} = 2.2 V.

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6.6 Typical Characteristics

At $V_{OUT(TYP)}$ = 3.3 V, V_{IN} = $V_{OUT(TYP)}$ + 0.5 V or 2.2 V (whichever is greater), I_{OUT} = 100 mA, V_{EN} = V_{IN}, C_{IN} = 1 µF, C_{OUT} = 4.7 µF, and C_{NR} = 0.01 µF, all temperature values refer to T_J (unless otherwise noted).

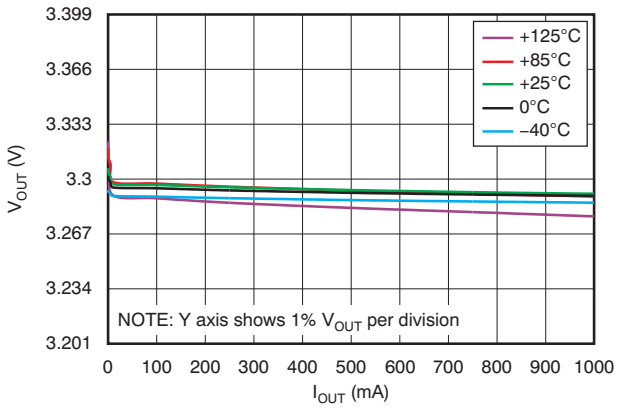

Figure 1. Load Regulation

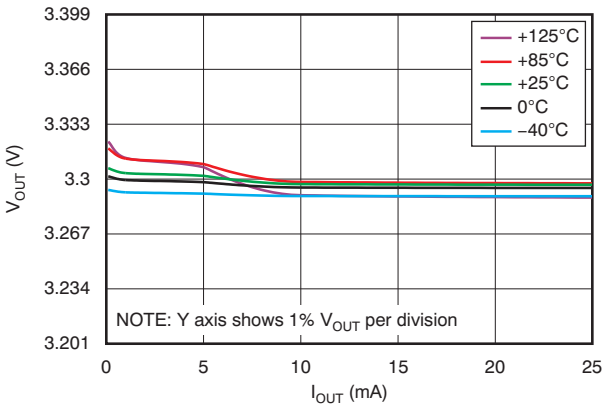

Figure 2. Load Regulation Under Light Loads

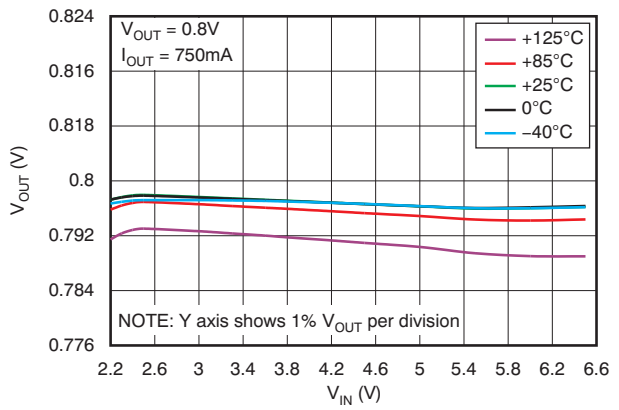

Figure 3. Line Regulation

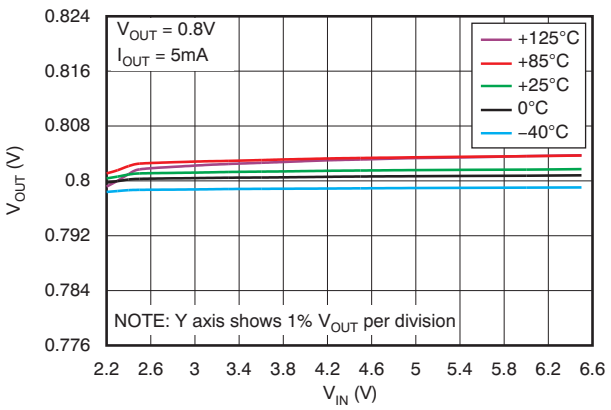

Figure 4. Line Regulation Under Light Loads

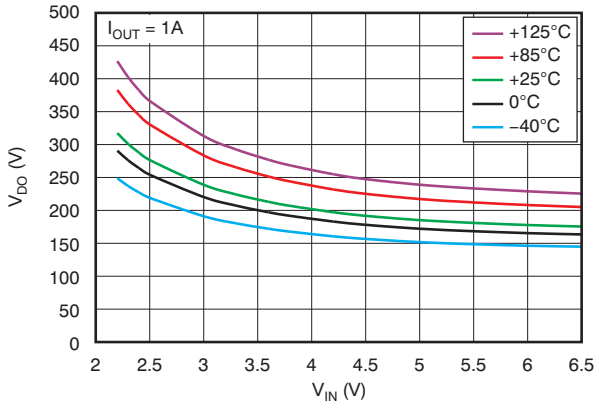

Figure 5. Dropout Voltage vs Input Voltage

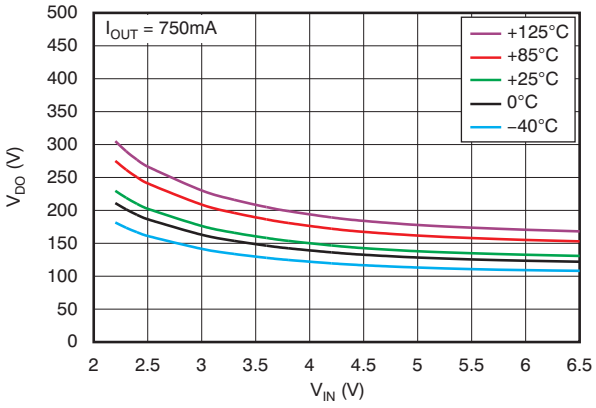

Figure 6. Dropout Voltage vs Input Voltage

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Typical Characteristics (continued)

At $V_{OUT(TYP)}$ = 3.3 V, V_{IN} = $V_{OUT(TYP)}$ + 0.5 V or 2.2 V (whichever is greater), I_{OUT} = 100 mA, V_{EN} = V_{IN}, C_{IN} = 1 µF, C_{OUT} = 4.7 µF, and C_{NR} = 0.01 µF, all temperature values refer to T_J (unless otherwise noted).

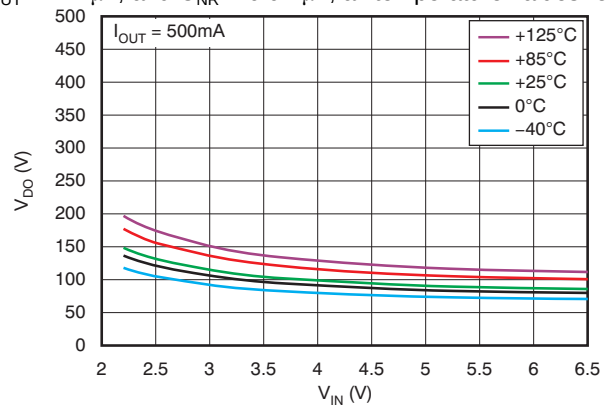

Figure 7. Dropout Voltage vs Input Voltage

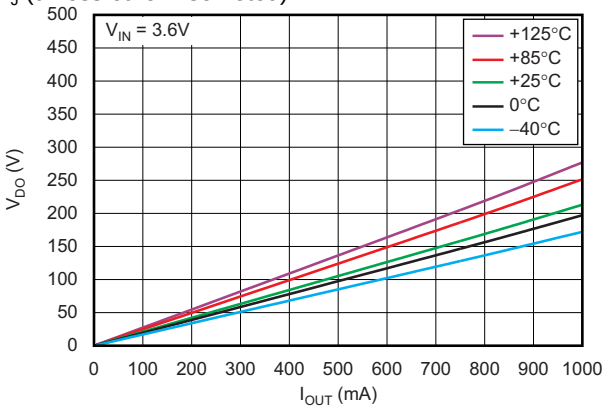

Figure 8. Dropout Voltage vs Load Current

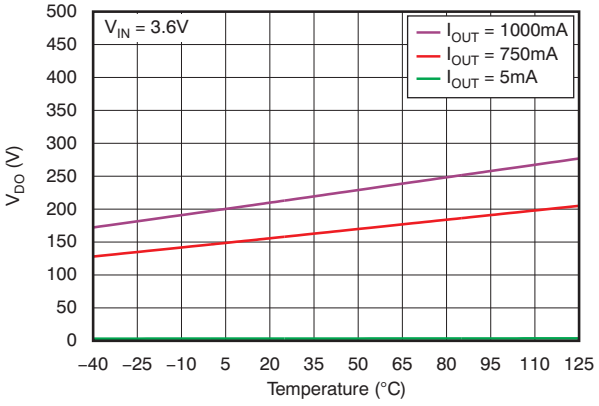

Figure 9. Dropout Voltage vs Temperature

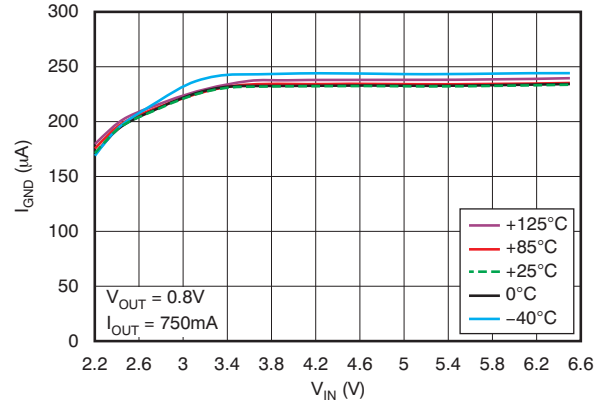

Figure 10. Ground Pin Current vs Input Voltage

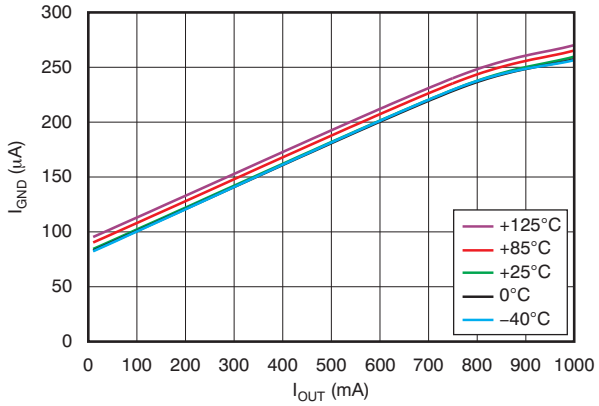

Figure 11. Ground Pin Current vs Load Current

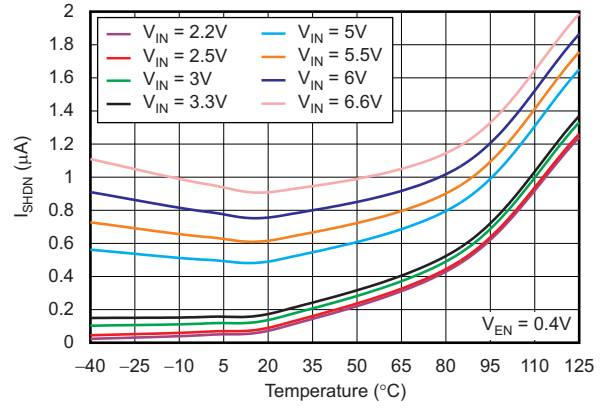

Figure 12. Shutdown Current vs Temperature

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Typical Characteristics (continued)

At $V_{OUT(TYP)}$ = 3.3 V, V_{IN} = $V_{OUT(TYP)}$ + 0.5 V or 2.2 V (whichever is greater), I_{OUT} = 100 mA, V_{EN} = V_{IN}, C_{IN} = 1 µF, C_{OUT} = 4.7 µF, and C_{NR} = 0.01 µF, all temperature values refer to T_J (unless otherwise noted).

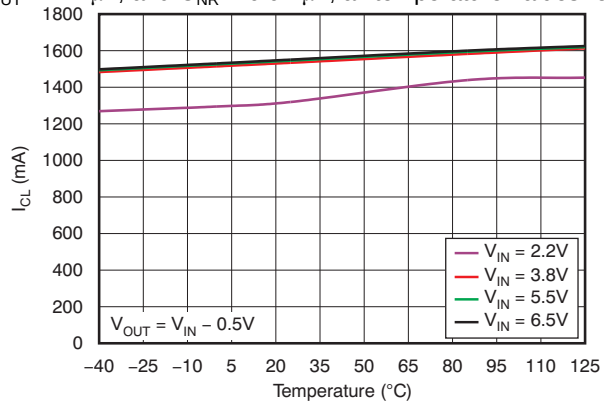

Figure 13. Current Limit vs Temperature

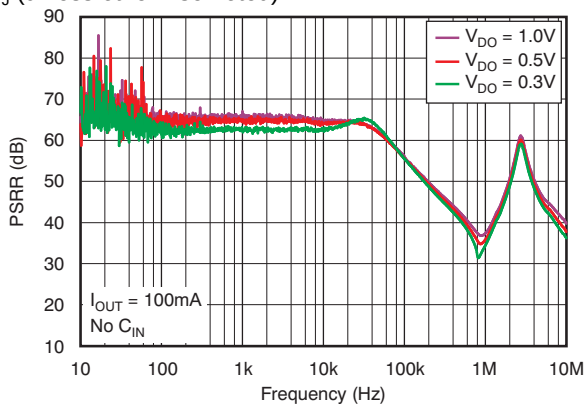

Figure 14. Power-Supply Ripple Rejection vs Frequency

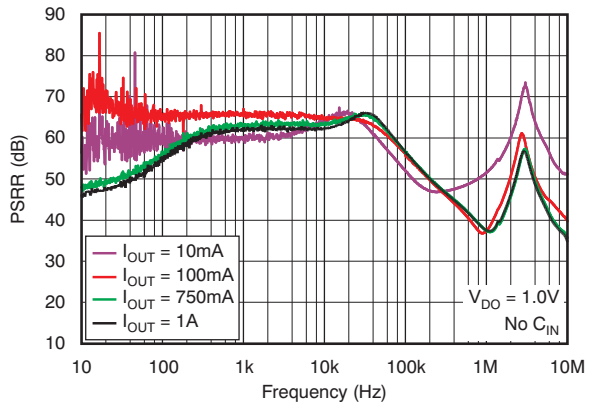

Figure 15. Power-Supply Ripple Rejection vs Frequency

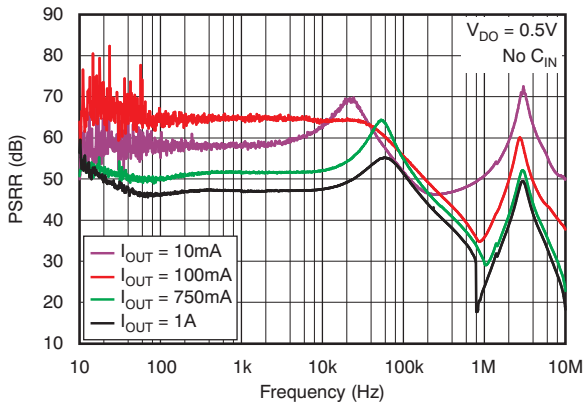

Figure 16. Power-Supply Ripple Rejection vs Frequency

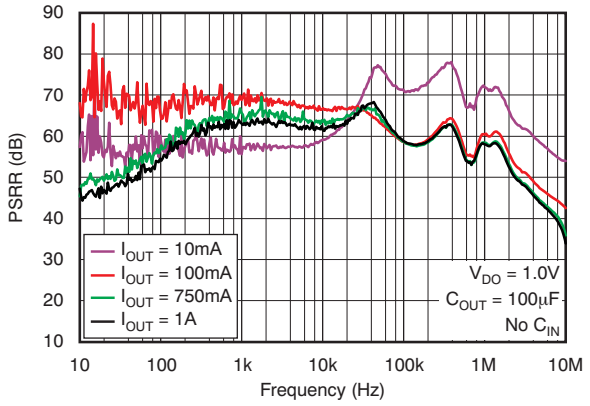

Figure 17. Power-Supply Ripple Rejection vs Frequency

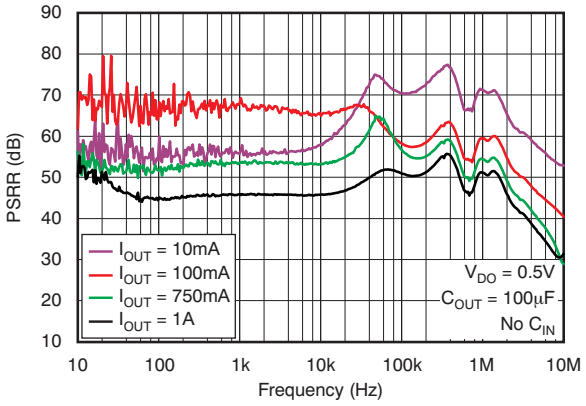

Figure 18. Power-Supply Ripple Rejection vs Frequency

Typical Characteristics (continued)

At $V_{OUT(TYP)}$ = 3.3 V, V_{IN} = $V_{OUT(TYP)}$ + 0.5 V or 2.2 V (whichever is greater), I_{OUT} = 100 mA, V_{EN} = V_{IN}, C_{IN} = 1 µF, C_{OUT} = 4.7 µF, and C_{NR} = 0.01 µF, all temperature values refer to T_J (unless otherwise noted).

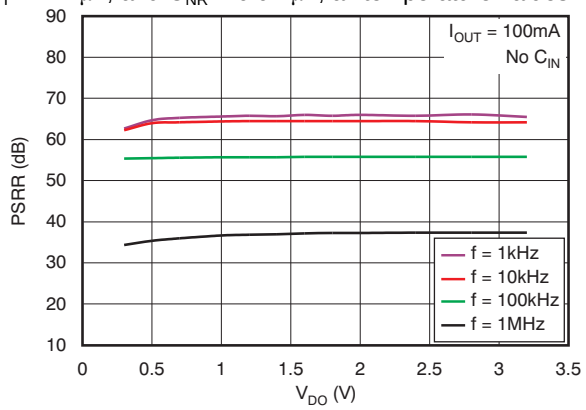

Figure 19. Power-Supply Ripple Rejection vs Dropout Voltage

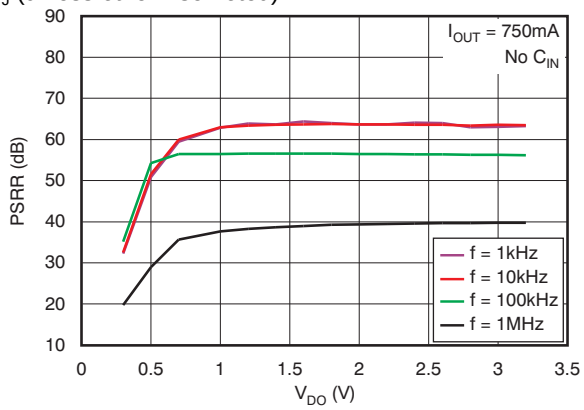

Figure 20. Power-Supply Ripple Rejection vs Dropout Voltage

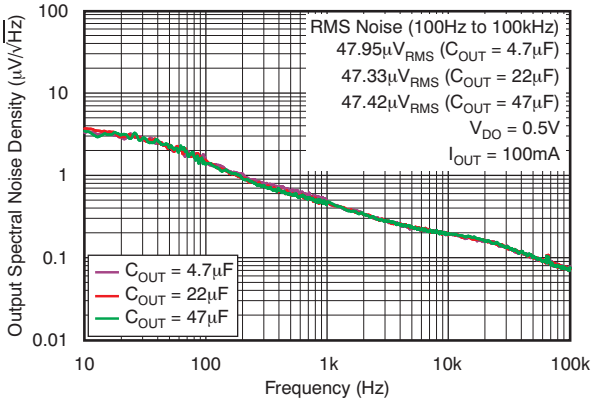

Figure 21. Output Spectral Noise Density vs Frequency

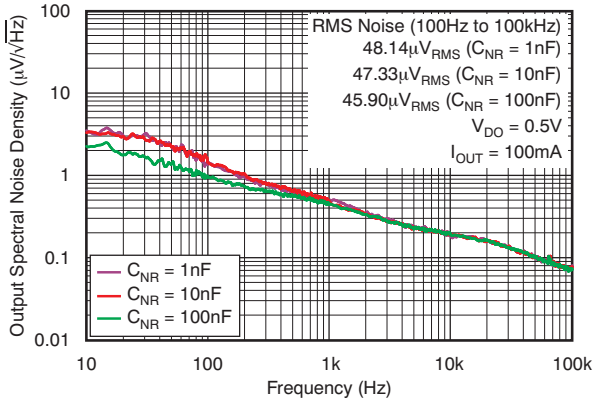

Figure 22. Output Spectral Noise Density vs Frequency

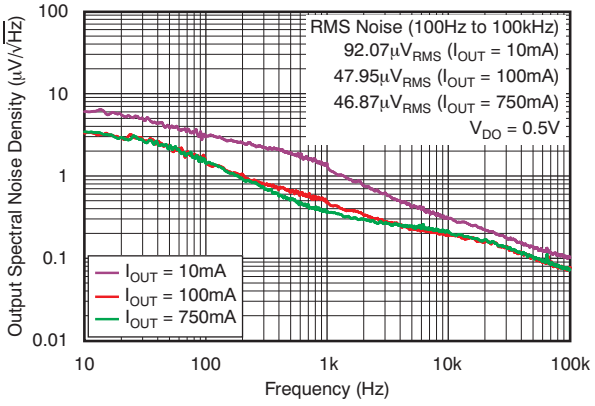

Figure 23. Output Spectral Noise Density vs Frequency

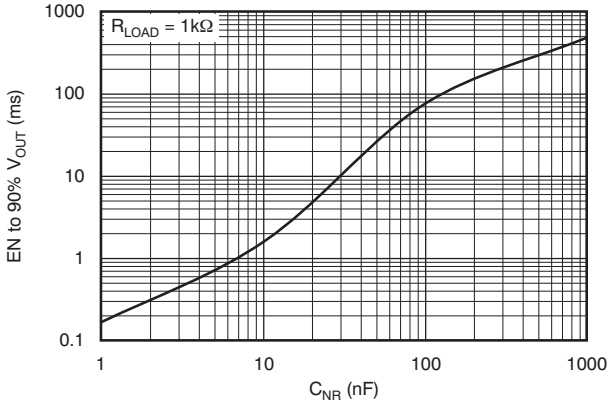

Figure 24. Start-Up Time vs Noise Reduction Capacitance

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Typical Characteristics (continued)

At $V_{OUT(TYP)}$ = 3.3 V, V_{IN} = $V_{OUT(TYP)}$ + 0.5 V or 2.2 V (whichever is greater), I_{OUT} = 100 mA, V_{EN} = V_{IN}, C_{IN} = 1 µF, C_{OUT} = 4.7 µF, and C_{NR} = 0.01 µF, all temperature values refer to T_J (unless otherwise noted).

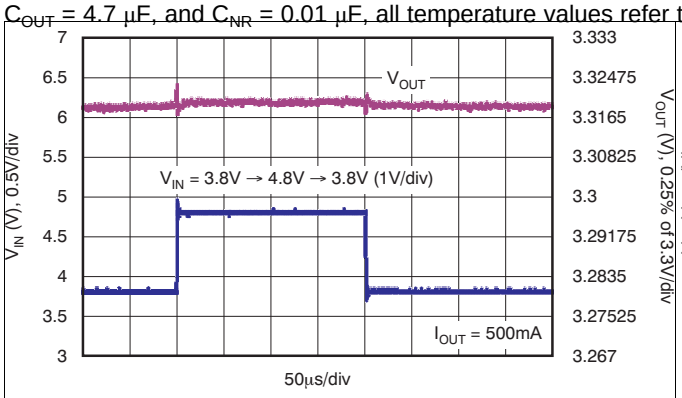


Figure 25. Line Transient Response

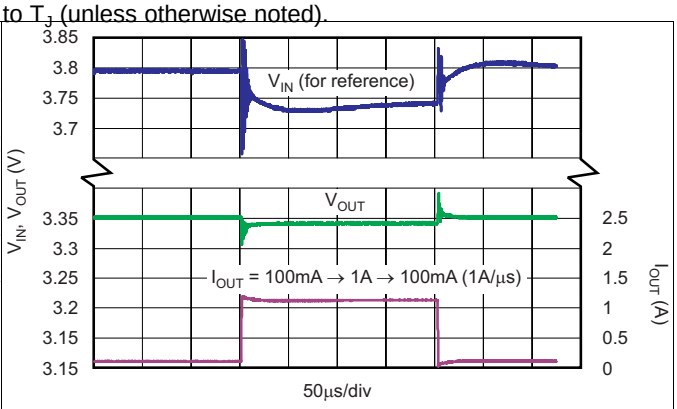


Figure 26. Load Transient Response

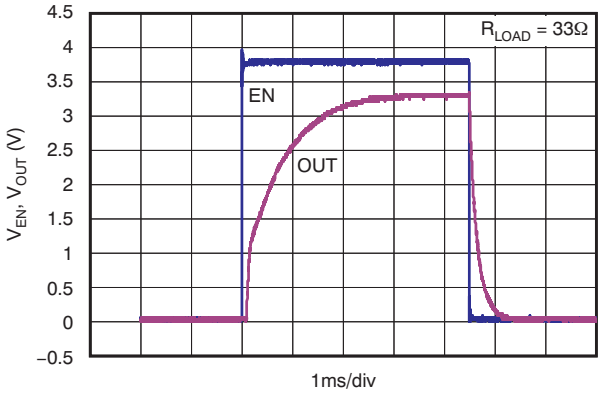
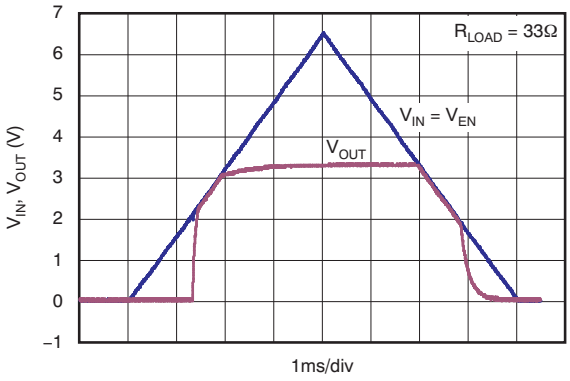


Figure 27. Enable Pulse Response



The internal reference requires approximately 2 ms of rampup time (see *Start-Up*); therefore, V_{OUT} fully reaches the target output voltage of 3.3 V in 2 ms from start-up.

Figure 28. Power-Up and Power-Down Response

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7 Detailed Description

7.1 Overview

The TPS7A80 devices belong to a family of new-generation LDO regulators that uses innovative circuitry to achieve wide bandwidth and high loop gain, resulting in extremely high PSRR (over a 1-MHz range), even with very low headroom (V_{IN} – V_{OUT}). A noise-reduction capacitor (C_{NR}) at the NR pin and a bypass capacitor (C_{BYPASS}) decrease noise generated by the band-gap reference to improve PSRR, while a quick-start circuit fastcharges the noise-reduction capacitor. This family of regulators offers sub-band-gap output voltages, current limit, and thermal protection, and is fully specified from –40°C to +125°C.

7.2 Functional Block Diagram

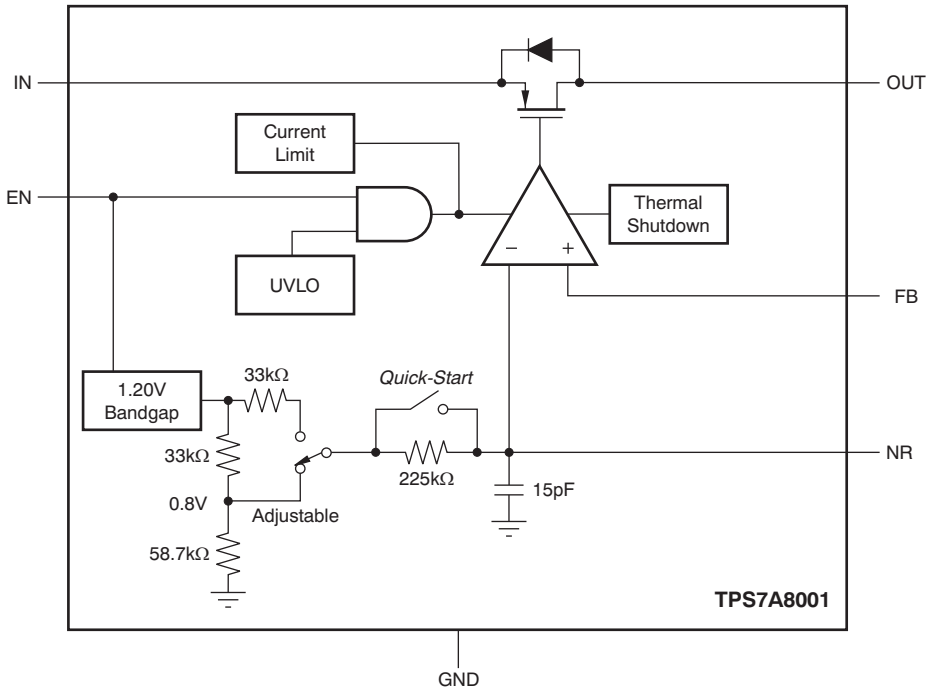

Figure 29. Adjustable Voltage Version

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Functional Block Diagram (continued)

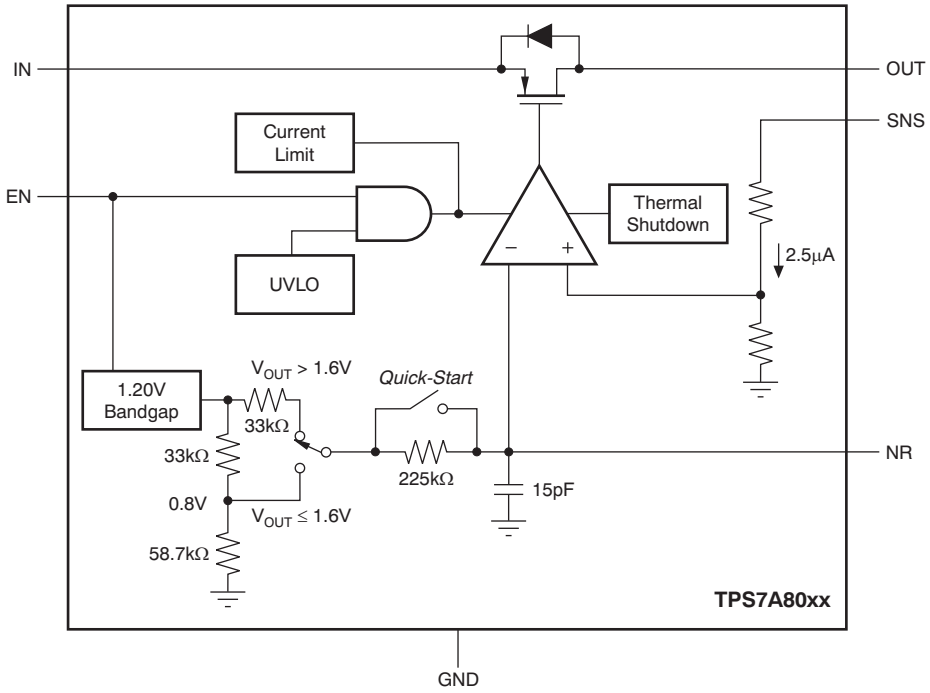

Figure 30. Fixed Voltage Versions

7.3 Feature Description

7.3.1 Internal Current Limit

The TPS7A80 internal current limit helps protect the regulator during fault conditions. During current limit, the output sources a fixed amount of current that is largely independent of output voltage. For reliable operation, do not operate these devices in a current limit state for extended periods of time.

The PMOS pass element in the TPS7A80 has a built-in body diode that conducts current when the voltage at OUT exceeds the voltage at IN. This current is not limited, so if extended reverse voltage operation is anticipated, external limiting is required.

7.3.2 Shutdown

The enable pin (EN) is active high and is compatible with standard and low voltage, TTL-CMOS levels. When shutdown capability is not required, EN can be connected to IN.

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Feature Description (continued)

7.3.3 Start-Up

Through a lower resistance, the band-gap reference can quickly charge the noise reduction capacitor (C_{NR}). The TPS7A80 have a *quick-start* circuit to quickly charge C_{NR}, if present; see the *Functional Block Diagram*. At start-up, this quick-start switch is closed, with only 33 kΩ of resistance between the band-gap reference and the NR pin. The quick-start switch opens approximately 2ms after any device enabling event, and the resistance between the band-gap reference and the NR pin becomes higher in value (approximately 250 kΩ) to form a very good low-pass (RC) filter. This low-pass filter achieves very good noise reduction for the reference voltage.

Inrush current can be a problem in many applications. The 33-kΩ resistance during the start-up period is intentionally put there to slow down the reference voltage ramp up, thus reducing the inrush current. For example, the capacitance of connecting the recommended C_{NR} value of 0.01 µF along with the 33-kΩ resistance causes approximately 1-ms RC delay. Start-up time with the other C_{NR} values can be calculated as Equation 1:

$$t_{STR}\ (s) = 76{,}000 \times C_{NR}\ (F) \quad (1)$$

Equation 1 is valid up to t_{STR} = 2 ms or C_{NR} = 26 nF, whichever is smaller.

Although the noise reduction effect is nearly saturated at 0.01 µF, connecting a C_{NR} value greater than 0.01 µF can help reduce noise slightly more; however, start-up time will be extremely long because the quick-start switch opens after approximately 2 ms. That is, if C_{NR} is not fully charged during this 2 ms period, C_{NR} finishes charging through a higher resistance of 250 kΩ, and takes much longer to fully charge.

A low leakage C_{NR} should be used; most ceramic capacitors are suitable.

7.3.4 Undervoltage Lockout (UVLO)

The TPS7A80 use an undervoltage lockout circuit to keep the output shut off until the internal circuitry is operating properly. The UVLO circuit has a deglitch feature so that it typically ignores undershoot transients on the input if they are less than 50-µs duration.

7.4 Device Functional Modes

Driving the EN pin over 1.2 V for V_{IN} from 2.2 V to 3.6 V or 1.35 V for V_{IN} from 3.6 V to 6.5 V turns on the regulator. Driving the EN pin below 0.4 V causes the regulator to enter shutdown mode.

In shutdown, the current consumption of the device is reduced to 0.02 µA, typically.

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8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The TPS7A80 devices belong to a family of new generation LDO regulators that use innovative circuitry to achieve wide bandwidth and high loop gain, resulting in extremely high PSRR (over a 1-MHz range) at very low headroom (V_{IN} – V_{OUT}). A noise reduction capacitor (C_{NR}) at the NR pin bypasses noise generated by the band-gap reference to improve PSRR, while a quick-start circuit fast-charges this capacitor. This family of regulators offers sub-band-gap output voltages, current limit, and thermal protection, and is fully specified from –40°C to 125°C.

Figure 31 gives the connections for the adjustable-output version (TPS7A8001). Figure 32 shows the connections for the fixed-voltage versions.

8.2 Typical Application

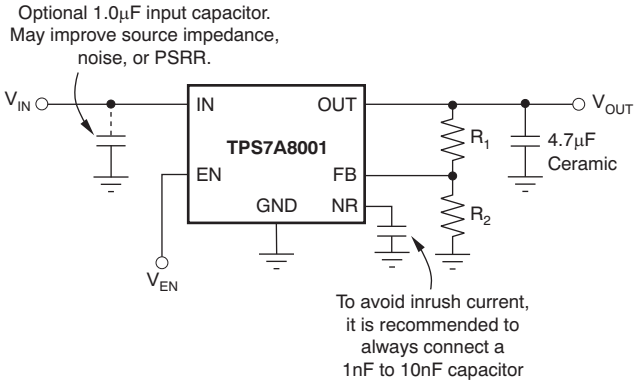

Figure 31. Typical Application Circuit: Adjustable-Voltage Version

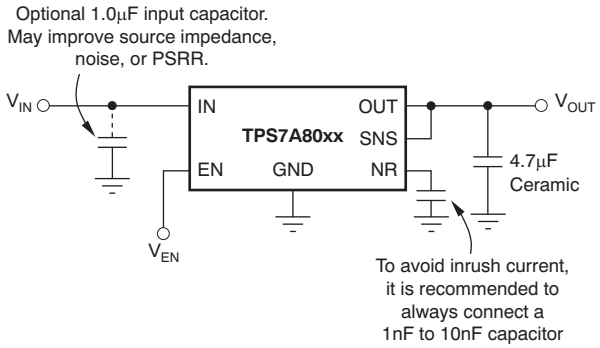

Figure 32. Typical Application Circuit: Fixed-Voltage Versions

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Typical Application (continued)

8.2.1 Design Requirements

8.2.1.1 Dropout Voltage

The TPS7A80 use a PMOS pass transistor to achieve low dropout. When (V_{IN} – V_{OUT}) is less than the dropout voltage (V_{DO}), the PMOS pass device is in its linear region of operation and the input-to-output resistance is the $R_{DS(ON)}$ of the PMOS pass element. V_{DO} scales approximately with output current because the PMOS device in dropout behaves the same way as a resistor.

As with any linear regulator, PSRR and transient response are degraded as (V_{IN} – V_{OUT}) approaches dropout. This effect is shown in Figure 19 and Figure 20 in the *Typical Characteristics* section.

8.2.1.2 Minimum Load

The TPS7A80 are stable and well-behaved with no output load. Traditional PMOS LDO regulators suffer from lower loop gain at very light output loads. The TPS7A80 employ an innovative low-current mode circuit to increase loop gain under very light or no-load conditions, resulting in improved output voltage regulation performance down to zero output current.

8.2.1.3 Input and Output Capacitor Requirements

Although an input capacitor is not required for stability, it is good analog design practice to connect a 0.1-μF to 1-μF low equivalent series resistance (ESR) capacitor across the input supply near the regulator. This capacitor counteracts reactive input sources and improves transient response, noise rejection, and ripple rejection. A higher-value capacitor may be necessary if large, fast rise-time load transients are anticipated or if the device is located several inches from the power source. If source impedance is not sufficiently low, a 0.1-μF input capacitor may be necessary to provide stability.

The TPS7A80 are designed to be stable with standard ceramic capacitors of capacitance values 4.7 μF or larger. These devices is evaluated using a 4.7-μF ceramic capacitor of 10-V rating, 10% tolerance, X5R type, and 0805 size (2 mm × 1.25 mm).

X5R- and X7R-type capacitors are highly recommended because they have minimal variation in value and ESR over temperature. Maximum ESR should be < 1 Ω.

The TPS7A80 implement an innovative internal compensation circuit that does not require a feedback capacitor across R_2 for stability. Do not use a feedback capacitor for this device.

8.2.1.4 Transient Response

As with any regulator, increasing the size of the output capacitor reduces over- and undershoot magnitude, but increases duration of the transient response.

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Typical Application (continued)

8.2.2 Detailed Design Procedure

The voltage on the FB pin sets the output voltage and is determined by the values of R_1 and R_2. The values of R_1 and R_2 can be calculated for any voltage using the formula given in Equation 2:

$$V_{OUT} = \frac{(R_1 + R_2)}{R_2} \times 0.800 \quad (2)$$

Sample resistor values for common output voltages are shown in Table 1. In Table 1, E96 series resistors are used, and all values meet 1% of the target V_{OUT}, assuming resistors with zero error. For the actual design, pay attention to any resistor error factors. Using lower values for R_1 and R_2 reduces the noise injected from the FB pin.

Table 1. Sample 1% Resistor Values for Common Output Voltages

V_{OUT}	R_1	R_2
0.8 V	0 Ω (Short)	Do not populate
1 V	2.49 kΩ	10 kΩ
1.2 V	4.99 kΩ	10 kΩ
1.5 V	8.87 kΩ	10 kΩ
1.8 V	12.5 kΩ	10 kΩ
2.5 V	21 kΩ	10 kΩ
3.3 V	30.9 kΩ	10 kΩ
5 V	52.3 kΩ	10 kΩ

8.2.2.1 Output Noise

In most LDOs, the band gap is the dominant noise source. If a noise reduction capacitor (C_{NR}) is used with the TPS7A80, the band gap does not contribute significantly to noise. Instead, noise is dominated by the output resistor divider and the error amplifier input. To minimize noise in a given application, use a 0.01-µF (minimum) noise-reduction capacitor.

Equation 3 approximates the total noise when C_{NR} = 0.01 µF:

$$V_N = 14.6 \times V_{OUT} + (\mu V_{RMS}) \quad (3)$$

8.2.3 Application Curve

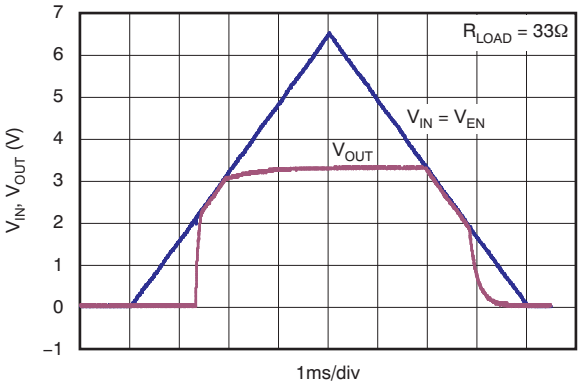

Figure 33. Power-Up and Power-Down Response

9 Power Supply Recommendations

These devices are designed to operate with an input voltage supply range from 2.2 V to 6.5 V. The input voltage range should provide adequate headroom for the device to have a regulated output. Use a well-regulated input supply. If the input supply is noisy, additional input capacitors with low ESR can help improve the output noise performance.

10 Layout

10.1 Layout Guidelines

10.1.1 Board Layout Recommendations to Improve PSRR and Noise Performance

To improve ac performance such as PSRR, output noise, and transient response, TI recommends designing the board with separate ground planes for V_{IN} and V_{OUT}, with each ground plane connected only at the GND pin of the device. In addition, the ground connection for the bypass capacitor should connect directly to the GND pin of the device.

10.1.2 Thermal Considerations

Thermal protection disables the output when the junction temperature rises to approximately 160°C, allowing the device to cool. When the junction temperature cools to approximately 140°C the output circuitry is again enabled. Depending on power dissipation, thermal resistance, and ambient temperature, the thermal protection circuit may cycle on and off. This cycling limits the dissipation of the regulator, protecting it from damage because of overheating.

Any tendency to activate the thermal protection circuit indicates excessive power dissipation or an inadequate heatsink. For reliable operation, junction temperature should be limited to 125°C maximum. To estimate the margin of safety in a complete design (including heatsink), increase the ambient temperature until the thermal protection is triggered; use worst-case loads and signal conditions. For good reliability, thermal protection should trigger at least 35°C above the maximum expected ambient condition of your particular application. This configuration produces a worst-case junction temperature of 125°C at the highest expected ambient temperature and worst-case load.

The internal protection circuitry of the TPS7A80 has been designed to protect against overload conditions. It was not intended to replace proper heatsinking. Continuously running the TPS7A80 into thermal shutdown degrades device reliability.

10.1.3 Power Dissipation

Knowing the device power dissipation and proper sizing of the thermal plane that is connected to the tab or pad is critical to avoiding thermal shutdown and ensuring reliable operation.

Power dissipation of the device depends on input voltage and load conditions and can be calculated using Equation 4:

$$P_D = (V_{IN} - V_{OUT}) \times I_{OUT} \quad (4)$$

Power dissipation can be minimized and greater efficiency can be achieved by using the lowest possible input voltage necessary to achieve the required output voltage regulation.

On the VSON (DRB) package, the primary conduction path for heat is through the exposed pad to the printed-circuit-board (PCB). The pad can be connected to ground or be left floating; however, it should be attached to an appropriate amount of copper PCB area to make sure the device does not overheat. The maximum junction-to-ambient thermal resistance depends on the maximum ambient temperature, maximum device junction temperature, and power dissipation of the device and is calculated using Equation 5:

$$R_{\theta JA} = \frac{(+125°C - T_A)}{P_D} \quad (5)$$

Knowing the maximum $R_{\theta JA}$, the minimum amount of PCB copper area needed for appropriate heatsinking is estimated using Figure 34.

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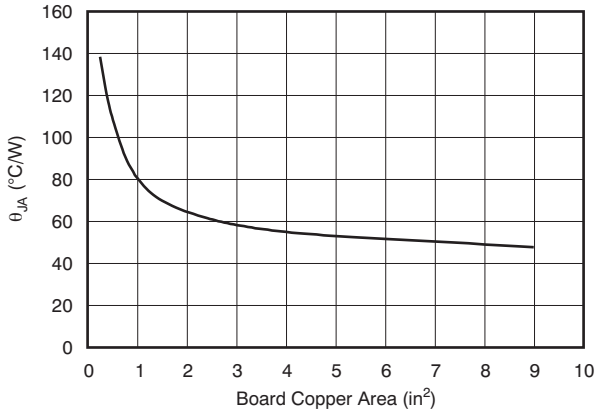
Layout Guidelines (continued)



NOTE: θ_{JA} value at board size of 9 in^2 (that is, 3 inches × 3 inches) is a JEDEC standard.

Figure 34. $R_{\theta JA}$ vs Board Size

Figure 34 shows the variation of θ_{JA} as a function of ground plane copper area in the board. It is intended only as a guideline to demonstrate the effects of heat spreading in the ground plane and should not be used to estimate actual thermal performance in real application environments.

NOTE

When the device is mounted on an application PCB, it is strongly recommended to use Ψ_{JT} and Ψ_{JB}, as explained in the section.

10.1.4 Estimating Junction Temperature

Using the thermal metrics Ψ_{JT} and Ψ_{JB}, as shown in the *Thermal Information* table, the junction temperature can be estimated with corresponding formulas (given in Equation 6). For backwards compatibility, an older $\theta_{JC,Top}$ parameter is listed as well.

$$\Psi_{JT}: \quad T_J = T_T + \Psi_{JT} \bullet P_D$$
$$\Psi_{JB}: \quad T_J = T_B + \Psi_{JB} \bullet P_D \tag{6}$$

Where P_D is the power dissipation shown by Equation 5, T_T is the temperature at the center-top of the IC package, and T_B is the PCB temperature measured 1 mm away from the IC package *on the PCB surface* (as Figure 36 shows).

NOTE

Both T_T and T_B can be measured on actual application boards using a thermo gun (an infrared thermometer).

For more information about measuring T_T and T_B, see *Using New Thermal Metrics*.

By looking at Figure 35, the new thermal metrics (Ψ_{JT} and Ψ_{JB}) have very little dependency onboard size. That is, using Ψ_{JT} or Ψ_{JB} with Equation 6 is a good way to estimate T_J by simply measuring T_T or T_B, regardless of the application board size.

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Layout Guidelines (continued)

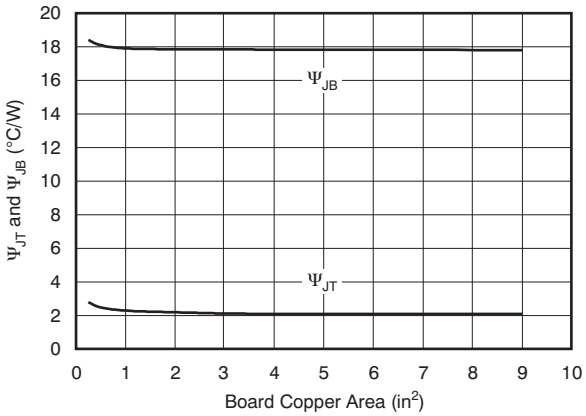

Figure 35. Ψ_{JT} and Ψ_{JB} vs Board Size

For a more detailed discussion of why TI does not recommend using $\theta_{JC(top)}$ to determine thermal characteristics, see *Using New Thermal Metrics*. For further information, see *Semiconductor and IC Package Thermal Metrics*.

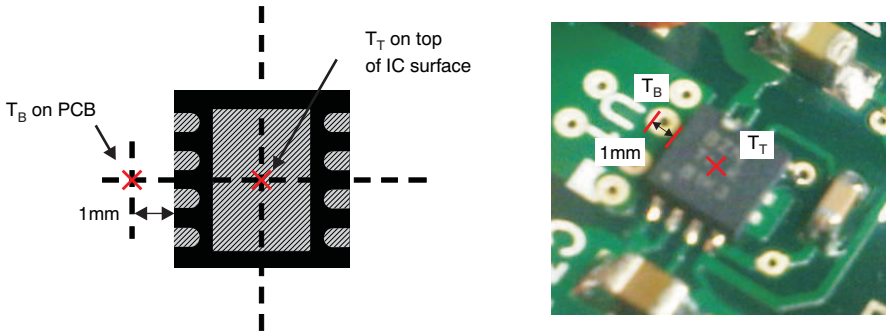

Figure 36. Measuring Points for T_T and T_B

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10.2 Layout Example

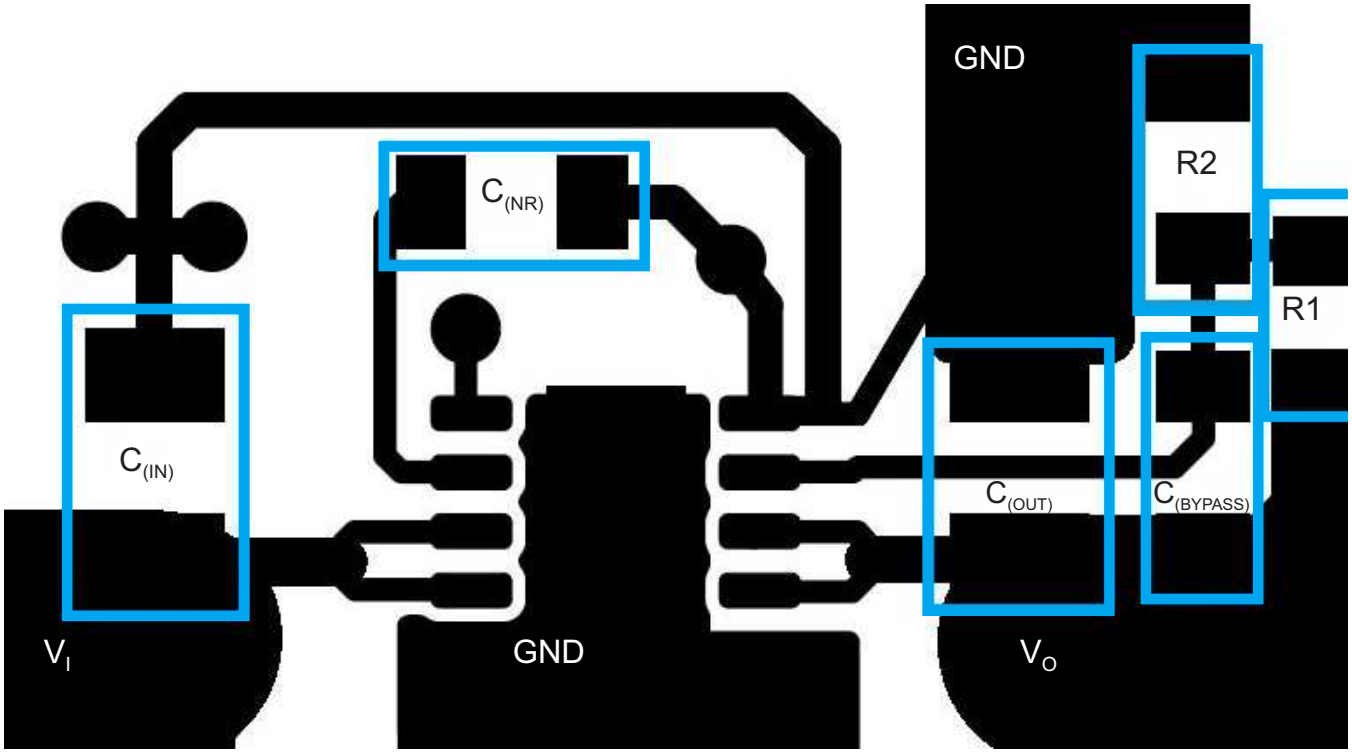

Figure 37. Layout Example

11 デバイスおよびドキュメントのサポート

11.1 ドキュメントのサポート

11.1.1 関連資料

関連資料については、以下を参照してください。

『TPS7A80xxDRBEVM ユーザー・ガイド』

11.2 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、ti.comのデバイス製品フォルダを開いてください。右上の隅にある「*通知を受け取る*」をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取れます。変更の詳細については、修正されたドキュメントに含まれている改訂履歴をご覧ください。

11.3 コミュニティ・リソース

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

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11.4 商標

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11.5 静電気放電に関する注意事項

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静電気放電はわずかな性能の低下から完全なデバイスの故障に至るまで、様々な損傷を与えます。高精度の集積回路は、損傷に対して敏感であり、極めてわずかなパラメータの変化により、デバイスに規定された仕様に適合しなくなる場合があります。

11.6 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。この情報は、そのデバイスについて利用可能な最新のデータです。このデータは予告なく変更されることがあり、ドキュメントが改訂される場合もあります。本データシートのブラウザ版を使用されている場合は、画面左側の説明をご覧ください。

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TPS7A8001DRBR	Active	Production	SON (DRB) | 8	3000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OFU
TPS7A8001DRBR.A	Active	Production	SON (DRB) | 8	3000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OFU
TPS7A8001DRBT	Active	Production	SON (DRB) | 8	250 | SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OFU
TPS7A8001DRBT.A	Active	Production	SON (DRB) | 8	250 | SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OFU
TPS7A8001DRBTG4	Active	Production	SON (DRB) | 8	250 | SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OFU
TPS7A8001DRBTG4.A	Active	Production	SON (DRB) | 8	250 | SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OFU
TPS7A8012DRBR	Active	Production	SON (DRB) | 8	3000 | LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G1H
TPS7A8012DRBR.A	Active	Production	SON (DRB) | 8	3000 | LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G1H
TPS7A8012DRBT	Active	Production	SON (DRB) | 8	250 | SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G1H
TPS7A8012DRBT.A	Active	Production	SON (DRB) | 8	250 | SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G1H
TPS7A8018DRBR	Active	Production	SON (DRB) | 8	3000 | LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G2H
TPS7A8018DRBR.A	Active	Production	SON (DRB) | 8	3000 | LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G2H
TPS7A8018DRBT	Active	Production	SON (DRB) | 8	250 | SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G2H
TPS7A8018DRBT.A	Active	Production	SON (DRB) | 8	250 | SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G2H
TPS7A8033DRBR	Active	Production	SON (DRB) | 8	3000 | LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G3H
TPS7A8033DRBR.A	Active	Production	SON (DRB) | 8	3000 | LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G3H
TPS7A8033DRBT	Active	Production	SON (DRB) | 8	250 | SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G3H
TPS7A8033DRBT.A	Active	Production	SON (DRB) | 8	250 | SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G3H
TPS7A8050DRBR	Active	Production	SON (DRB) | 8	3000 | LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G4H
TPS7A8050DRBR.A	Active	Production	SON (DRB) | 8	3000 | LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G4H
TPS7A8050DRBRG4	Active	Production	SON (DRB) | 8	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	1G4H
TPS7A8050DRBRG4.A	Active	Production	SON (DRB) | 8	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	1G4H
TPS7A8050DRBT	Active	Production	SON (DRB) | 8	250 | SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G4H
TPS7A8050DRBT.A	Active	Production	SON (DRB) | 8	250 | SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1G4H

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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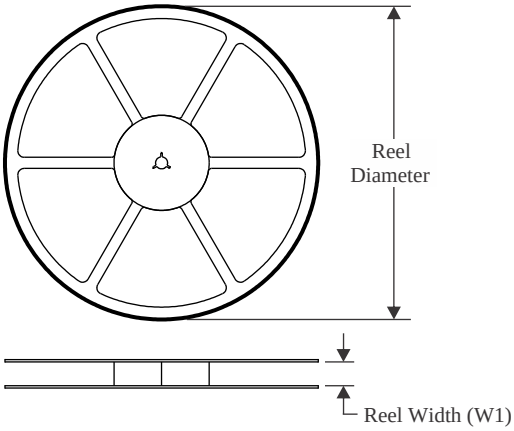
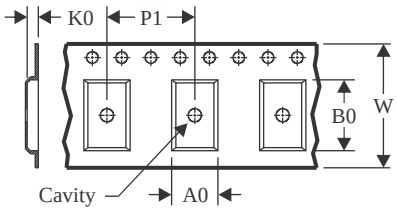
TAPE AND REEL INFORMATION

REEL DIMENSIONS

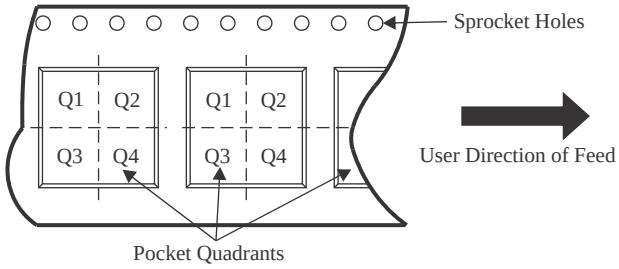


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

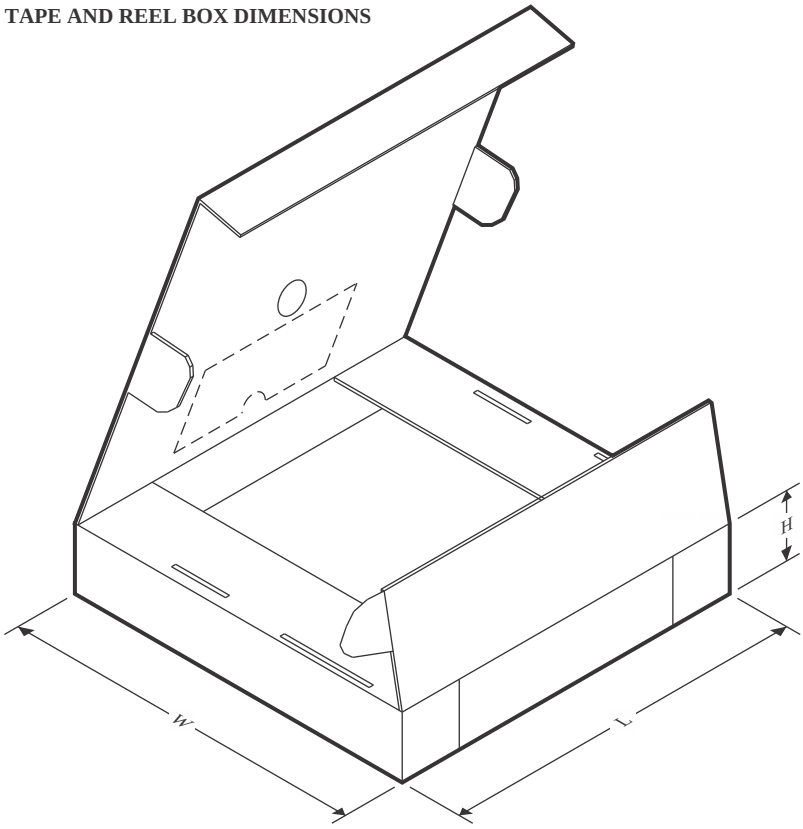
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS7A8001DRBR	SON	DRB	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS7A8001DRBT	SON	DRB	8	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS7A8001DRBT	SON	DRB	8	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS7A8001DRBTG4	SON	DRB	8	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS7A8012DRBR	SON	DRB	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS7A8012DRBT	SON	DRB	8	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS7A8018DRBR	SON	DRB	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS7A8018DRBT	SON	DRB	8	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS7A8033DRBR	SON	DRB	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS7A8033DRBT	SON	DRB	8	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS7A8050DRBR	SON	DRB	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS7A8050DRBRG4	SON	DRB	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS7A8050DRBT	SON	DRB	8	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS7A8001DRBR	SON	DRB	8	3000	346.0	346.0	33.0
TPS7A8001DRBT	SON	DRB	8	250	213.0	191.0	35.0
TPS7A8001DRBT	SON	DRB	8	250	210.0	185.0	35.0
TPS7A8001DRBTG4	SON	DRB	8	250	210.0	185.0	35.0
TPS7A8012DRBR	SON	DRB	8	3000	360.0	360.0	36.0
TPS7A8012DRBT	SON	DRB	8	250	210.0	185.0	35.0
TPS7A8018DRBR	SON	DRB	8	3000	360.0	360.0	36.0
TPS7A8018DRBT	SON	DRB	8	250	210.0	185.0	35.0
TPS7A8033DRBR	SON	DRB	8	3000	360.0	360.0	36.0
TPS7A8033DRBT	SON	DRB	8	250	210.0	185.0	35.0
TPS7A8050DRBR	SON	DRB	8	3000	360.0	360.0	36.0
TPS7A8050DRBRG4	SON	DRB	8	3000	367.0	367.0	35.0
TPS7A8050DRBT	SON	DRB	8	250	210.0	185.0	35.0

GENERIC PACKAGE VIEW

DRB 8 VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

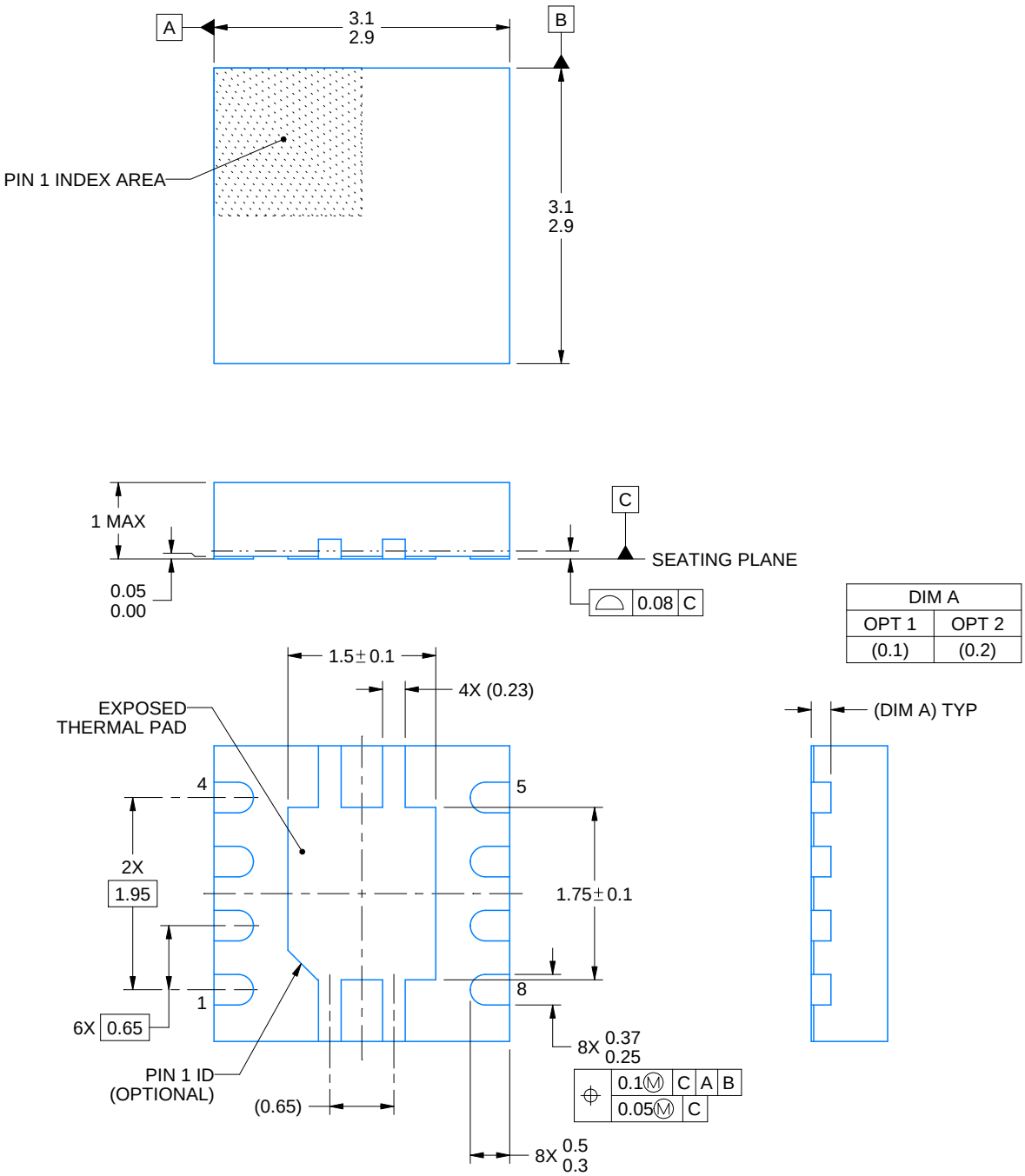
Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

DRB0008A

PACKAGE OUTLINE

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES:

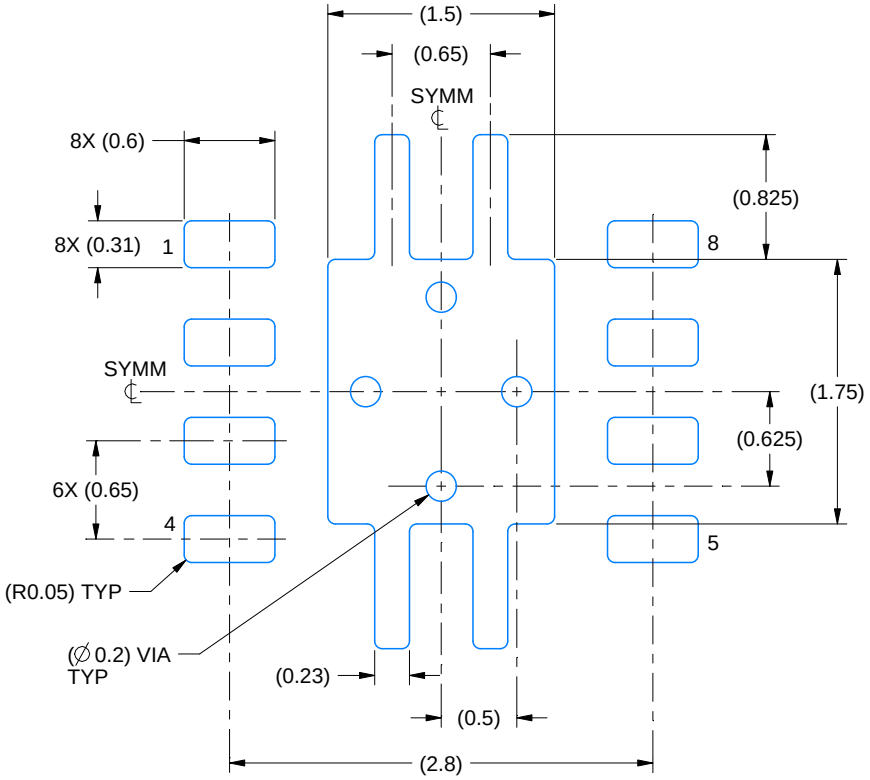
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

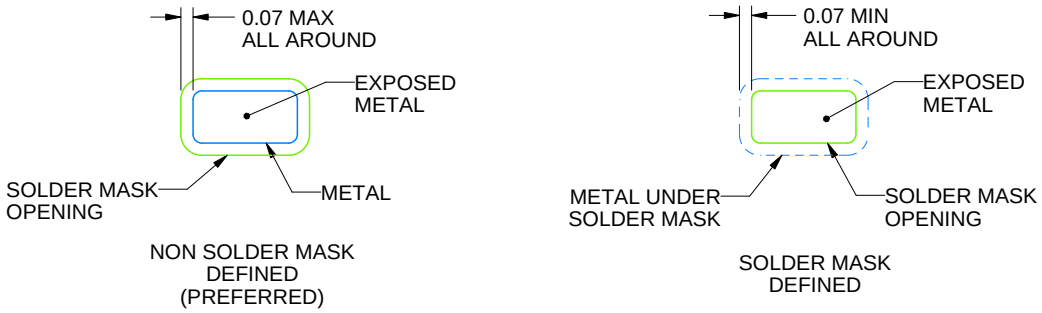
DRB0008A

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:20X

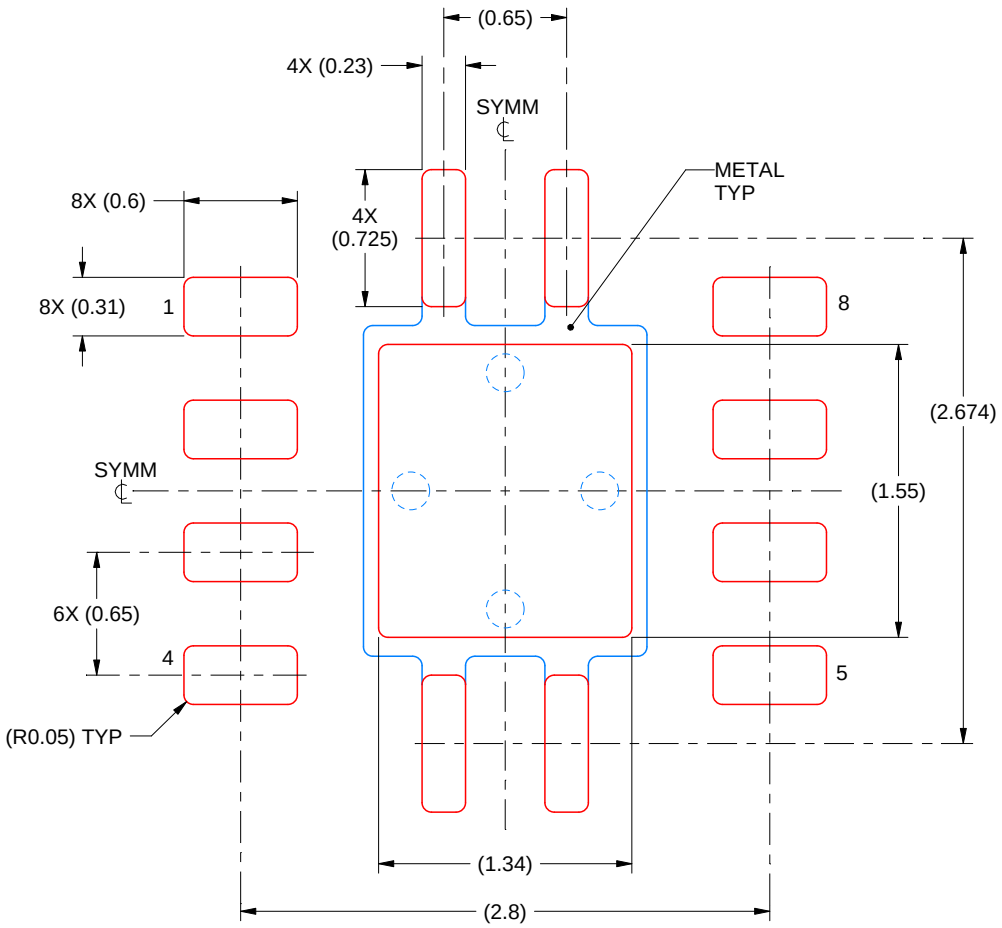


SOLDER MASK DETAILS

4218875/A 01/2018

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
84% PRINTED SOLDER COVERAGE BY AREA
SCALE:25X

4218875/A 01/2018

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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最終更新日：2025 年 10 月